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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/516,428	CHI ET AL.	
Examiner	Art Unit	
Michael Szperka	1644	

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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
updated inventor search Chi, Francis Lu, Tian	10/13/06	MS
updated USPAT USPGPUB EPO JPO DERWENT (EAST) see search printouts	10/13/2006	MS
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